

STL11N3LLH6

Datasheet - production data

N-channel 30 V, 0.006 Ω typ., 11 A STripFET[™] VI DeepGATE[™] Power MOSFET in a PowerFLAT[™] 3.3 x 3.3 package

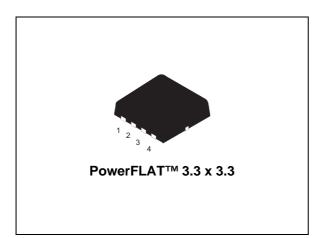
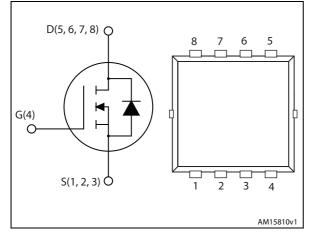


Figure 1. Internal schematic diagram



Features

Order code	V_{DS}	R _{DS(on)} max.	I _D
STL11N3LLH6	30 V	0.0075 Ω	11 A ⁽¹⁾

1. The value is rated according $R_{thj-pcb.}$

- R_{DS(on)} * Q_g industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

Applications

• Switching applications

Description

This device is an N-channel Power MOSFET developed using the 6th generation of STripFETTM DeepGATETM technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest $R_{DS(on)}$ in all packages.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL11N3LLH6	11N3L	PowerFLAT™ 3.3 x 3.3	Tape and reel

This is information on a product in full production.

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	30	V
V _{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _{pcb} = 25 °C	11	А
I _D ⁽¹⁾	Drain current (continuous) at T _{pcb} = 100 °C	6.9	А
$I_{DM}^{(2)}$	Drain current (pulsed)	44	А
P _{TOT} ⁽³⁾	Total dissipation at $T_{C} = 25 \text{ °C}$	50	W
P _{TOT} ⁽¹⁾	Total dissipation at T _{pcb} = 25 °C	2	W
	Derating factor	0.03	W/°C
TJ	Operating junction temperature	-55 to 150	°C
T _{stg}	Storage temperature	-55 10 150	°C

Table 2.	Absolute	maximum	ratings
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1. The value is rated according $R_{thj-pcb}$.

2. Pulse width limited by safe operating area.

3. The value is rated according R_{thj-c} .

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R _{thj-case} ⁽²⁾	Thermal resistance junction-case	2.5	°C/W
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb	42.8	°C/W
R _{thj-pcb} ⁽²⁾	Thermal resistance junction-pcb	63.5	°C/W

1. When mounted on FR-4 board of $1inch^2$, 2oz Cu, t < 10 sec.

2. Steady state.



2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. Offort States						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	30			V
	Zero gate voltage drain	$V_{GS} = 0, V_{DS} = 30 V$			1	μA
I _{DSS}	current	V _{GS} = 0, V _{DS} = 30 V, T _C =125 °C			10	μA
I _{GSS}	Gate body leakage current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1			V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5.5 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 5.5 \text{ A}$		0.006 0.0084	0.0075 0.0095	Ω Ω

Table 4	On/off	states
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Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1690	-	pF
C _{oss}	Output capacitance	V _{DS} = 24 V, f=1 MHz,	-	290	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} =0	-	176	-	pF
Qg	Total gate charge	V _{DD} = 24 V, I _D = 11 A	-	17	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 4.5 V	-	8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 14)	-	6	-	nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	-	1.7	-	Ω

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	9.5	-	ns
t _r	Rise time	V_{DD} = 24 V, I _D = 5.5 A, R _G = 4.7 Ω, V _{GS} = 10 V	-	30	-	ns
t _{d(off)}	Turn-off delay time	$K_G = 4.7 \Omega_2, V_{GS} = 10 V$ (see Figure 13)	-	37	-	ns
t _f	Fall time		-	12	-	ns



Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current		-		11	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		44	А
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 11 \text{ A}, V_{GS} = 0$	-		1.1	V
t _{rr}	Reverse recovery time	I _{SD} = 11 A,	-	24		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs,	-	16.8		nC
I _{RRM}	Reverse recovery current	V _{DD} = 24 V	-	1.4		А

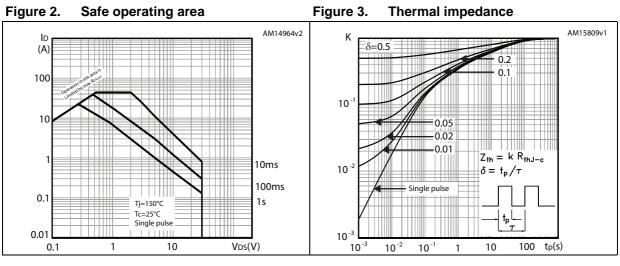
Table 7. Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration=300µs, duty cycle 1.5%.

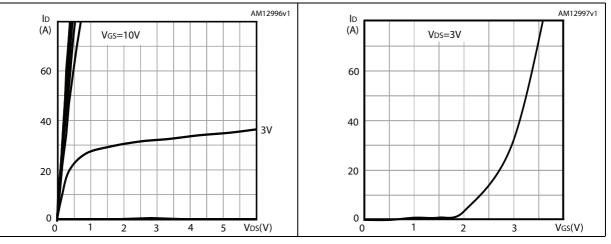


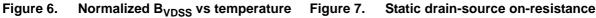
2.1 Electrical characteristics (curves)

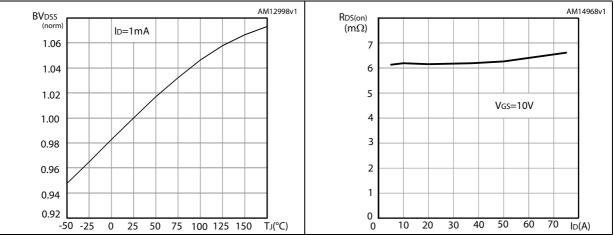














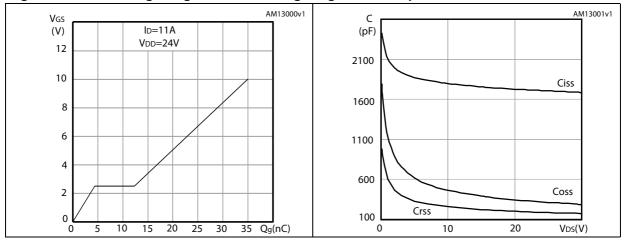
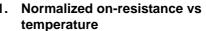


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Norma vs temperature temperature



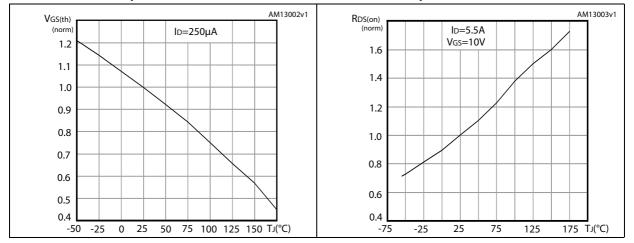
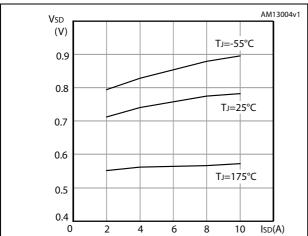


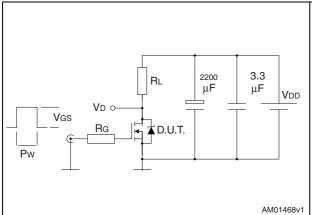
Figure 12. Source-drain diode forward characteristics





3 Test circuits

Figure 13. Switching times test circuit for resistive load



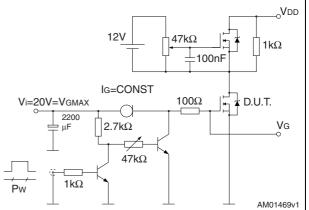
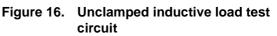
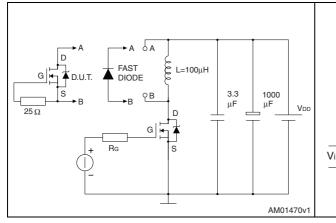


Figure 14. Gate charge test circuit

Figure 15. Test circuit for inductive load switching and diode recovery times





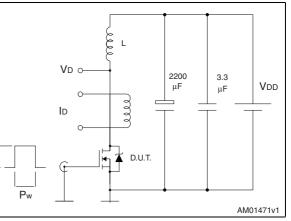
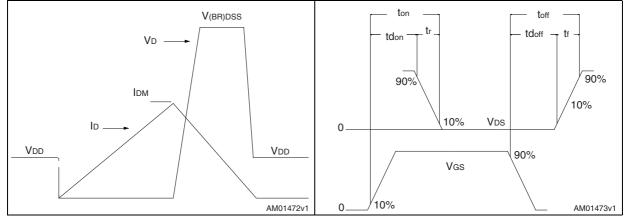




Figure 18. Switching time waveform



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4 Package mechanical data

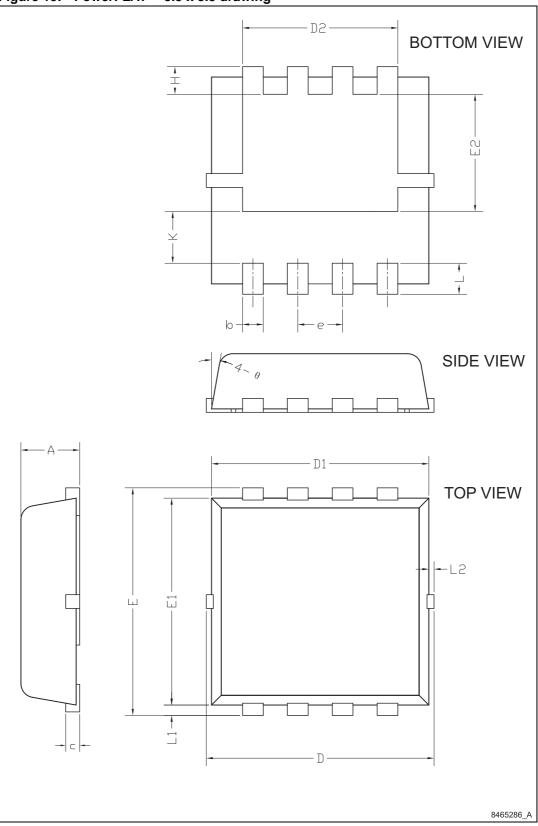
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		mm	
Dim. —	Min.	Тур.	Max.
A	0.70	0.80	0.90
b	0.25	0.30	0.39
С	0.14	0.15	0.20
D	3.10	3.30	3.50
D1	3.05	3.15	3.25
D2	2.15	2.25	2.35
е	0.55	0.65	0.75
E	3.10	3.30	3.50
E1	2.90	3.00	3.10
E2	1.60	1.70	1.80
н	0.25	0.40	0.55
К	0.65	0.75	0.85
L	0.30	0.45	0.60
L1	0.05	0.15	0.25
L2			0.15
ϑ	8°	10°	12°

Table 8. PowerFLAT[™] 3.3 x 3.3 mechanical data







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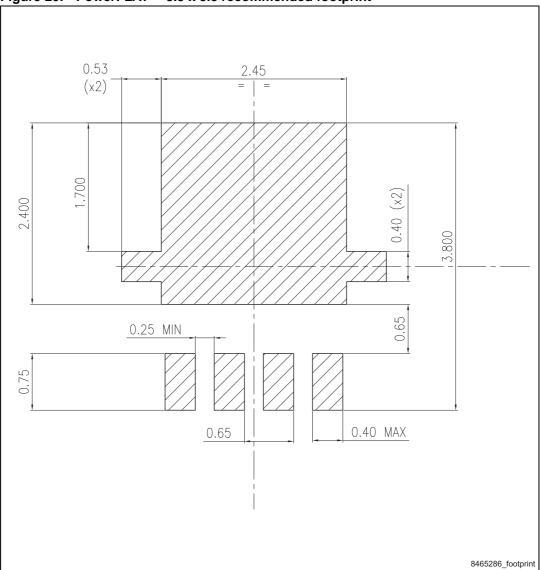


Figure 20. PowerFLAT[™] 3.3 x 3.3 recommended footprint^(a)

a. All dimensions are in millimeters



5 Revision history

Date	Revision	Changes
02-Sep-2010	1	First release.
23-May-2013	2	 Document status promoted from preliminary data to production data. Updated: <i>Figure 1</i>, silhouette in cover page and <i>Section 4: Package mechanical data</i> Modified: the entire typical values in <i>Table 7</i> Minor text changes



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